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INFO	RMATION I	MSC.	OSTIRE	Application Number	10/749552	
_	TEMENT BY			Filing Date	January 2, 2004	
31A				First Named Inventor	Kazuo NISHI et al.	
	(use as many sheets o	is necessi	ary)	Group Art Unit	2915	
				Examiner Name	Warren	
Sheet	1	of -	1	Attorney Docket Number	0756-7243	

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Examiner Signature	Matthew E. Wann	Date Considered	5/31/05	

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Substitu	ste for form 1449A/PTO)		Complete if Known		
INEC	DRMATION	DISC	LOSURE	Application Number	10/749,552	
AFE.	TEMENT BY	VADD	LOSCIA	Filing Date	January 2, 2004	
PRIN	TENENID	IAFF	LICANI	First Named Inventor	Kazuo NISHI et al.	
	(us Palynamy sheet	s as necesso	מרץ)	Group Art Unit	2815	
	20 7004 55		Examiner Name	Worker		
Sheet	1 6	of	1	Attorney Docket Number	0756-7243	

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Examiner on the Same	Date 5/31/05
Signature / Marie a / Marie	Considered

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	RMATION I		OSIDE	Application Number	10/749,552
				Filing Date	January 2, 2004
51A	TEMENT BY			First Named Inventor	Kazuo NISHI et al.
	(use as many sheets a	is necesso	(עיי	Group Art Unit	2815
				Examiner Name	M. Warren
Sheet	1	of	1	Attorney Docket Number	0756-7243

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Examiner Initials	Cite No.		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.)., date, page(s), volume-issue number(s), publisher, city and/or country where published.					T ²
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Examiner Signature	Mouthen E. Wanen	Date Considered	5/31/05

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